

## A new-structure magnetic memory device developed

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Schematics of structures for three kinds of spin-orbit-torque-induced magnetization scheme. (a) The first previous structure where the magnetization is perpendicular to the film plane. (b) The second previous structure where the magnetization is in-plane and orthogonal to channel current. (c) The new structure where the magnetization is in-plane and collinear with the current. Credit: Shunsuke Fukami

The research group of Professor Hideo Ohno and Associate Professor Shunsuke Fukami of Tohoku University has developed a new-structure magnetic memory device utilizing spin-orbit- torque-induced magnetization switching.

For these two decades, much effort has been devoted to the development of magnetic random access memories (MRAMs), which store



information as the <u>magnetization direction</u> of a magnet. Since the magnetization can, be in general, be reversed at high speed unlimitedly, the MRAMs are regarded as a promising replacement for currently-used semiconductor-based working memories such as static random access memories (SRAMs) and dynamic random access memories (DRAMs), which are now facing several serious issues.

The central issue of the MRAM development is how to achieve magnetization reversal efficiently.

Recently, spin-orbit-torque (SOT)-induced magnetization switching where torques brought about by an in-plane current through the spinorbit interactions are utilized - was demonstrated and intensively studied. In principle, the SOT-induced switching allows for an ultrafast magnetization reversal in a nanosecond timescale.

The research group of Tohoku University showed a new scheme of SOTinduced magnetization switching. Whereas there had been two kinds of switching schemes where the magnetization is directed orthogonally to the applied write current, the present structure has the magnetization directing collinear with the current. The group fabricated three-terminal devices with the new structure, where a Ta/CoFeB/MgO-based magnetic tunnel junction is used, and successfully demonstrated the switching operation.





Experimental result of the resistance versus applied current density under the perpendicular field of -15 mT (a), and +15 mT (b). The fact that the switching direction depends on the sign of the perpendicular field indicates that the spin-orbit torque drives the magnetization reversal. Credit: Shunsuke Fukami

The required current density to induce the magnetization switching was reasonably small and the resistance difference between "0" and "1" states was reasonably large, indicating that the new structure is a promising candidate for the MRAM applications.

In addition, the group showed that the new structure has the potential to serve as a useful tool to go deeply into the physics of SOT-induced switching, in which a number of unrevealed issues remain.

The magnetic memory device can store the information without power supply, allowing a drastic reduction of the power consumption of integrated circuits. In particular, this benefit becomes significant for



applications that have relatively long standby times, such as sensor nodes which are likely to perform important roles in future IoT (Internet of Things) societies.

In this regard, the present work is expected to pave the way toward the realization of ultralow-power and high-performance integrated circuits and IoT societies.

**More information:** A spin-orbit torque switching scheme with collinear magnetic easy axis and current configuration, *Nature Nanotechnology*, <u>DOI: 10.1038/NNANO2016.29</u>

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